Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
09695228	MARKO ET AL.
Examiner	Art Unit
Tran, Hai	2623

SEARCHED						
Class	Subclass	Date	Examiner			
348	441	02/02/2007	HVT			
370	389	02/02/2007	HVT			
725	75,131,139,151	02/14/2011	FEH			
370	394,473-474	02/14/2011	FEH			

SEARCH NOTES			
Search Notes	Date	Examiner	
Updated Search	02/002/2007	HVT	
Updated Search	08/20/2010	FEH	
Considered 101 and 112 issues	08/20/2010	FEH	
Inventorship Searched	08/20/2010	FEH	
See Enclosed East Search	02/14/2011	FEH	
Inventorship Searched	02/14/2011	FEH	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
725	131,139,151	02/14/2011	FEH

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